TOSHIBA 2SK2972

TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE (π-MOS V)

# 2 S K 2 9 7 2

HIGH SPEED, HIGH VOLTAGE SWITCHING APPLICATIONS SWITCHING REGULATOR APPLICATIONS

Low Drain-Source ON Resistance :  $R_{DS(ON)} = 0.75 \Omega$  (Typ.)

High Forward Transfer Admittance:  $|Y_{fS}| = 7.0 \text{ S}$  (Typ.)

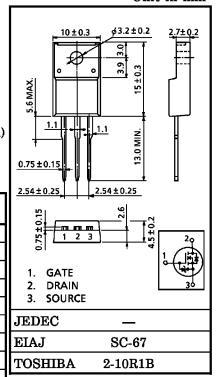
Low Leakage Current :  $I_{DSS} = 100 \,\mu\text{A}$  (Max.) ( $V_{DS} = 500 \,\text{V}$ )

Enhancement-Mode :  $V_{th} = 2.5 \sim 4.5 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA)}$ 

### MAXIMUM RATINGS (Ta = 25°C)

| CHARACTERIS             | SYMBOL                     | RATING            | UNIT                 |   |
|-------------------------|----------------------------|-------------------|----------------------|---|
| Drain-Source Voltage    | $v_{ m DSS}$               | 500               | V                    |   |
| Drain-Gate Voltage (RG  | $v_{ m DGR}$               | 500               | V                    |   |
| Gate-Source Voltage     | $v_{GSS}$                  | ±30               | V                    |   |
| Drain Current           | DC                         | $I_{\mathbf{D}}$  | 10                   | A |
|                         | Pulse                      | $I_{\mathbf{DP}}$ | 32                   | A |
| Drain Power Dissipation | $P_{\mathbf{D}}$           | 40                | W                    |   |
| Single Pulse Avalanche  | EAS                        | 312               | mJ                   |   |
| Avalanche Current       | $I_{AR}$                   | 8                 | A                    |   |
| Repetitive Avalanche En | $\mathbf{E}_{\mathbf{AR}}$ | 4                 | mJ                   |   |
| Channel Temperature     | ${ m T_{ch}}$              | 150               | °C                   |   |
| Storage Temperature Ra  | $\mathrm{T_{stg}}$         | -55~150           | $^{\circ}\mathrm{C}$ |   |

## INDUSTRIAL APPLICATIONS Unit in mm



### THERMAL CHARACTERISTICS

|  | SYMBOL                 |       |      |
|--|------------------------|-------|------|
| Thermal Resistance, Channel to Case    | R <sub>th (ch-c)</sub> | 3.125 | °C/W |
| Thermal Resistance, Channel to Ambient | R <sub>th (ch-a)</sub> | 62.5  | °C/W |

- \* Repetitive rating; Pulse Width Limited by Max. junction temperature.
- \*\*  $V_{DD} = 90 \text{ V}$ , Starting  $T_{ch} = 25^{\circ}\text{C}$ , L = 8.3 mH,  $R_G = 25 \Omega$ ,  $I_{AR} = 8 \text{ A}$

This transistor is an electrostatic sensitive device. Please handle with caution.

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### ELECTRICAL CHARACTERISTICS (Ta = 25°C)

| CHARA   | CTERISTIC        | SYMBOL                              | TEST CONDITION   | MIN. | TYP. | MAX. | UNIT    |
|---|------------------|-------------------------------------|--|------|------|------|---------|
| Gate Leakage  | e Current        | IGSS                                | $V_{GS} = \pm 25 V, V_{DS} = 0 V$  | _    | _    | ±10  | $\mu$ A |
| Gate-Source :<br>Voltage                            | Breakdown        | V <sub>(BR)</sub> GSS               | $I_{G} = \pm 10 \mu\text{A},  V_{DS} = 0  \text{V}$  | ±30  | _    | _    | v       |
| Drain Cut-off                                       | f Current        | $I_{ m DSS}$                        | $V_{DS} = 500 \text{ V}, \ V_{GS} = 0 \text{ V}$   | _    | _    | 100  | $\mu$ A |
| Drain-Source<br>Voltage                             | Breakdown        | V (BR) DSS                          | $I_{ m D} = 10 \ { m mA}, \ { m V}_{ m GS} = 0 \ { m V}$   | 500  | _    | _    | v       |
| Gate Thresho  | old Voltage      | $v_{ m th}$                         | $V_{\mathrm{DS}} = 10  \mathrm{V},  \mathrm{I}_{\mathrm{D}} = 1  \mathrm{mA}$  | 2.5  | _    | 4.5  | V       |
| Drain-Source  | ON Resistance    | RDS (ON)                            | $V_{GS} = 10 \text{ V}, I_{D} = 5 \text{ A}$   | _    | 0.75 | 0.85 | Ω       |
| Forward Trai  | nsfer Admittance | Y <sub>fs</sub>                     | $V_{DS} = 10 \text{ V}, I_{D} = 5 \text{ A}$   | 3.5  | 7.0  | _    | S       |
| Input Capaci  | tance            | Ciss                                | V  | _    | 1300 | _    |         |
| Reverse Transfer Capacitance                        |                  | $C_{rss}$                           | $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$<br>f = 1  MHz   | _    | 120  | _    | pF      |
| Output Capa   | citance          | $C_{OSS}$                           |  | _    | 400  | _    |         |
| Switching<br>Time                                   | Rise Time        | t <sub>r</sub>                      | $V_{GS} \stackrel{10 \text{ V}}{_{0}\text{ V}} \stackrel{I_{D} = 4 \text{ A}}{_{0}\text{ V}_{OUT}}$ $R_{L} = 50 \Omega$ $V_{IN} : t_{r}, t_{f} < 5 \text{ ns}, V_{DD} = 200 \text{ V}$ $Duty \le 1\%, t_{w} = 10 \mu \text{s}$ | _    | 26   | _    |         |
|   | Turn-on Time     | $t_{\mathbf{on}}$                   |  | _    | 45   | _    | ns      |
|   | Fall Time        | tf                                  |  | _    | 40   | _    | 115     |
|   | Turn-off Time    | t <sub>off</sub>                    |  | I    | 160  | _    |         |
| Total Gate Charge (Gate-<br>Source Plus Gate-Drain) |                  | $\mathbf{Q}_{\mathbf{g}}$           | $V_{DD} = 400 \text{ V}, V_{GS} = 10 \text{ V},$   | _    | 30   | _    | nC      |
| Gate-Source Charge                                  |                  | $\mathbf{Q}_{\mathbf{g}\mathbf{s}}$ | $I_{\mathbf{D}}=8\mathtt{A}$   | _    | 17   | _    | ] "     |
| Gate-Drain ("Miller") Charge                        |                  | $\mathbf{Q}_{\mathbf{gd}}$          |  |      | 13   | _    |         |

## SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (Ta = 25°C)

| CHARACTERISTIC                      | SYMBOL            | TEST CONDITION                  | MIN. | TYP. | MAX. | UNIT    |
|-------------------------------------|-------------------|---------------------------------|------|------|------|---------|
| Continuous Drain Reverse<br>Current | $I_{ m DR}$       | _                               | _    | _    | 10   | A       |
| Pulse Drain Reverse Current         | $I_{ m DRP}$      | <del>-</del>                    |      | _    | 32   | Α       |
| Diode Forward Voltage               | ${ m v_{DSF}}$    | $I_{DR} = 8 A, V_{GS} = 0 V$    | _    | _    | -1.7 | V       |
| Reverse Recovery Time               | $t_{rr}$          | $I_{DR} = 8 A$ , $V_{GS} = 0 V$ | _    | 1200 | _    | ns      |
| Reverse Recovery Charge             | $\mathbf{Q_{rr}}$ | $dI_{DR}/dt = 100 A/\mu s$      | _    | 10   | _    | $\mu$ C |

### **MARKING**

